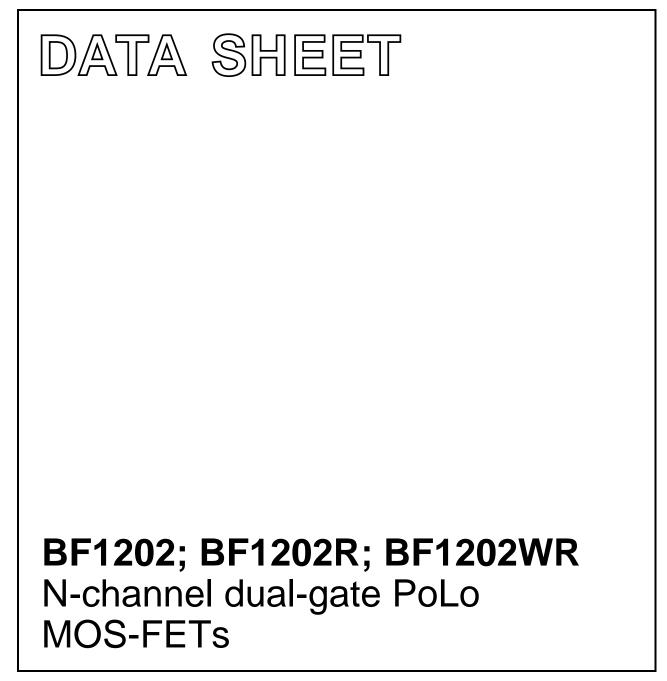
DISCRETE SEMICONDUCTORS



Product specification Supersedes data of 2000 Mar 29 2010 Sep 16



N-channel dual-gate PoLo MOS-FETs BF1202; BF1202R; BF1202WR

FEATURES

- Short channel transistor with high forward transfer admittance to input capacitance ratio
- Low noise gain controlled amplifier
- Partly internal self-biasing circuit to ensure good cross-modulation performance during AGC and good DC stabilization.

APPLICATIONS

 VHF and UHF applications with 3 to 9 V supply voltage, such as digital and analogue television tuners and professional communications equipment.

DESCRIPTION

Enhancement type N-channel field-effect transistor with source and substrate interconnected. Integrated diodes between gates and source protect against excessive input voltage surges. The BF1202, BF1202R and BF1202WR are encapsulated in the SOT143B, SOT143R and SOT343R plastic packages respectively.

QUICK REFERENCE DATA

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V _{DS}	drain-source voltage		_	-	10	V
ID	drain current		-	-	30	mA
P _{tot}	total power dissipation		-	_	200	mW
y _{fs}	forward transfer admittance		25	30	40	mS
C _{ig1-ss}	input capacitance at gate 1		-	1.7	2.2	pF
C _{rss}	reverse transfer capacitance	f = 1 MHz	-	15	30	fF
F	noise figure	f = 800 MHz	-	1.1	1.8	dB
X _{mod}	cross-modulation	input level for k = 1% at 40 dB AGC	100	105	-	dBμV
Tj	operating junction temperature		-	-	150	°C

CAUTION

This product is supplied in anti-static packing to prevent damage caused by electrostatic discharge during transport and handling.

PINNING

PIN	DESCRIPTION
1	source
2	drain
3	gate 2
4	gate 1

Marking code legend:

- * = : made in Hong Kong
- * = p : made in Hong Kong
- * = t : made in Malaysia

Top view

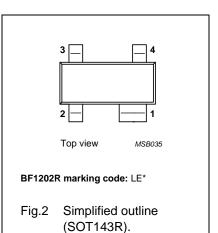
Fig.1

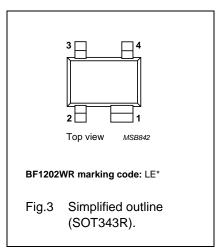
BF1202 marking code: LD*

Simplified outline

(SOT143B).

MSB014





BF1202; BF1202R; BF1202WR

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 60134).

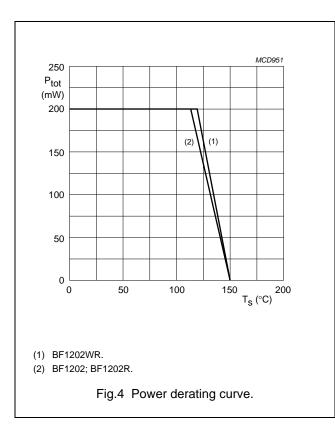
SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V _{DS}	drain-source voltage		-	10	V
I _D	drain current		_	30	mA
I _{G1}	gate 1 current		_	±10	mA
I _{G2}	gate 2 current		—	±10	mA
P _{tot}	total power dissipation				
	BF1202; BF1202R	$T_s \le 113 \text{ °C}$; note 1	_	200	mW
	BF1202WR	$T_s \le 119 \ ^{\circ}C$; note 1	_	200	mW
T _{stg}	storage temperature		-65	+150	°C
Tj	operating junction temperature		_	150	°C

Note

1. $\ensuremath{ T_s}$ is the temperature of the soldering point of the source lead.

THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	VALUE	UNIT
R _{th j-s}	thermal resistance from junction to soldering point		
	BF1202; BF1202R	185	K/W
	BF1202WR	155	K/W



BF1202; BF1202R; BF1202WR

STATIC CHARACTERISTICS

$T_i = 25 \ ^{\circ}C$ unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V _{(BR)DSS}	drain-source breakdown voltage	$V_{G1-S} = V_{G2-S} = 0; I_D = 10 \ \mu A$	10	-	V
V _{(BR)G1-SS}	gate 1-source breakdown voltage	$V_{G2-S} = V_{DS} = 0; I_{G1-S} = 10 \text{ mA}$	6	_	V
V _{(BR)G2-SS}	gate 2-source breakdown voltage	$V_{G1-S} = V_{DS} = 0; I_{G2-S} = 10 \text{ mA}$	6	_	V
V _{(F)S-G1}	forward source-gate 1 voltage	$V_{G2-S} = V_{DS} = 0; I_{S-G1} = 10 \text{ mA}$	0.5	1.5	V
V _{(F)S-G2}	forward source-gate 2 voltage	$V_{G1-S} = V_{DS} = 0; I_{S-G2} = 10 \text{ mA}$	0.5	1.5	V
V _{G1-S(th)}	gate 1-source threshold voltage	$V_{G2-S} = 4 \text{ V}; V_{DS} = 5 \text{ V}; I_D = 100 \ \mu\text{A}$	0.3	1.0	V
V _{G2-S(th)}	gate 2-source threshold voltage	$V_{G1-S} = 5 \text{ V}; V_{DS} = 5 \text{ V}; I_D = 100 \ \mu\text{A}$	0.3	1.2	V
I _{DSX}	drain-source current	$V_{G2-S} = 4 \text{ V}; V_{DS} = 5 \text{ V}; R_{G1} = 120 \text{ k}\Omega;$ note 1	8	16	mA
I _{G1-SS}	gate 1 cut-off current	$V_{G2-S} = V_{DS} = 0; V_{G1-S} = 5 V$	-	50	nA
I _{G2-SS}	gate 2 cut-off current	$V_{G1-S} = V_{DS} = 0; V_{G2-S} = 4 V$	-	20	nA

Note

1. R_{G1} connects G_1 to $V_{GG} = 5$ V.

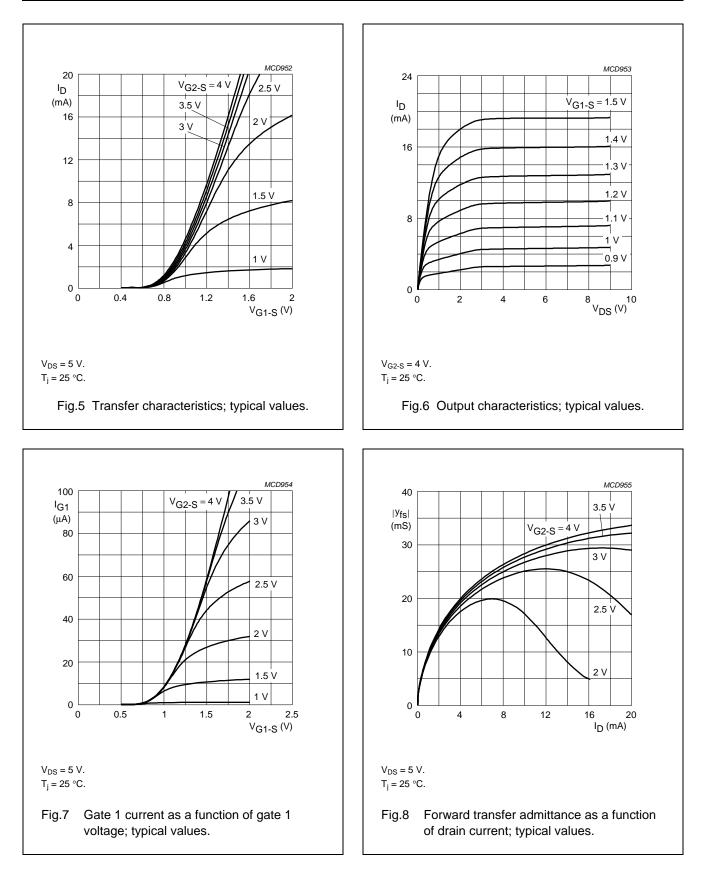
DYNAMIC CHARACTERISTICS

Common source; $T_{amb} = 25 \text{ °C}$; $V_{G2-S} = 4 \text{ V}$; $V_{DS} = 5 \text{ V}$; $I_D = 12 \text{ mA}$; unless otherwise specified.

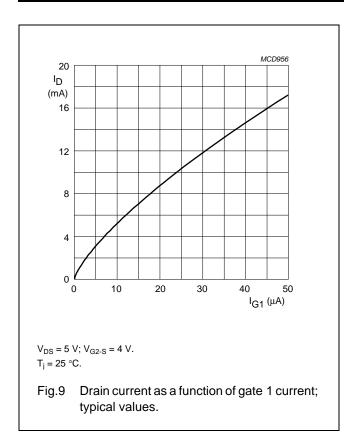
SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
y _{fs}	forward transfer admittance	pulsed; T _j = 25 °C	25	30	40	mS
C _{ig1-ss}	input capacitance at gate 1	f = 1 MHz	-	1.7	2.2	pF
C _{ig2-ss}	input capacitance at gate 2	f = 1 MHz	-	1	_	pF
C _{oss}	output capacitance	f = 1 MHz	-	0.85	-	pF
C _{rss}	reverse transfer capacitance	f = 1 MHz	-	15	30	fF
F	noise figure	f = 10.7 MHz; G _S = 20 mS; B _S = 0	-	9	11	dB
		$f = 400 \text{ MHz}; Y_S = Y_{S \text{ opt}}$	-	0.9	1.5	dB
		$f = 800 \text{ MHz}; Y_S = Y_{S \text{ opt}}$	-	1.1	1.8	dB
G _{tr}	power gain	f = 200 MHz; G_S = 2 mS; B_S = $B_{S opt}$; G_L = 0.5 mS; B_L = $B_{L opt}$	-	34.5	-	dB
		$f = 400 \text{ MHz}; G_S = 2 \text{ mS}; B_S = B_{S \text{ opt}};$ $G_L = 1 \text{ mS}; B_L = B_{L \text{ opt}}$	-	30.5	-	dB
		$ f = 800 \text{ MHz}; \text{G}_{\text{S}} = 3.3 \text{ mS}; \text{B}_{\text{S}} = \text{B}_{\text{S opt}}; \\ \text{G}_{\text{L}} = 1 \text{ mS}; \text{B}_{\text{L}} = \text{B}_{\text{L opt}} $	_	26.5	-	dB
X _{mod}	cross-modulation	input level for k = 1%; $f_w = 50 \text{ MHz}$; $f_{unw} = 60 \text{ MHz}$; note 1				
		at 0 dB AGC	90	-	-	dBμV
		at 10 dB AGC	-	92	_	dBμV
		at 40 dB AGC	100	105	_	dBµV

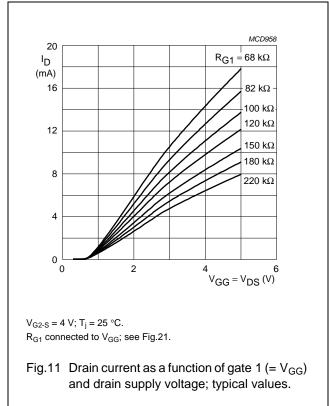
Note

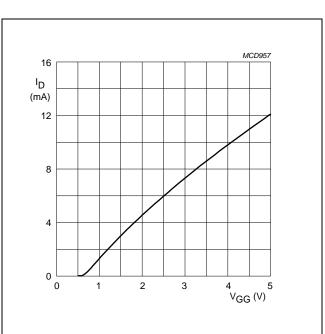
1. Measured in Fig.21 test circuit.



BF1202; BF1202R; BF1202WR

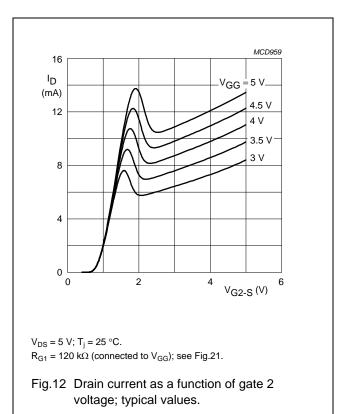


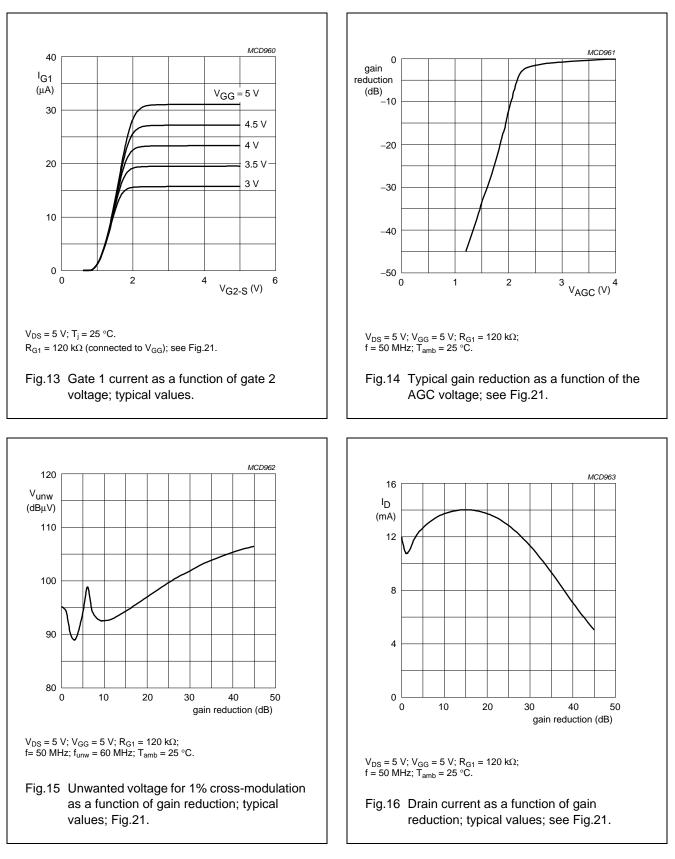


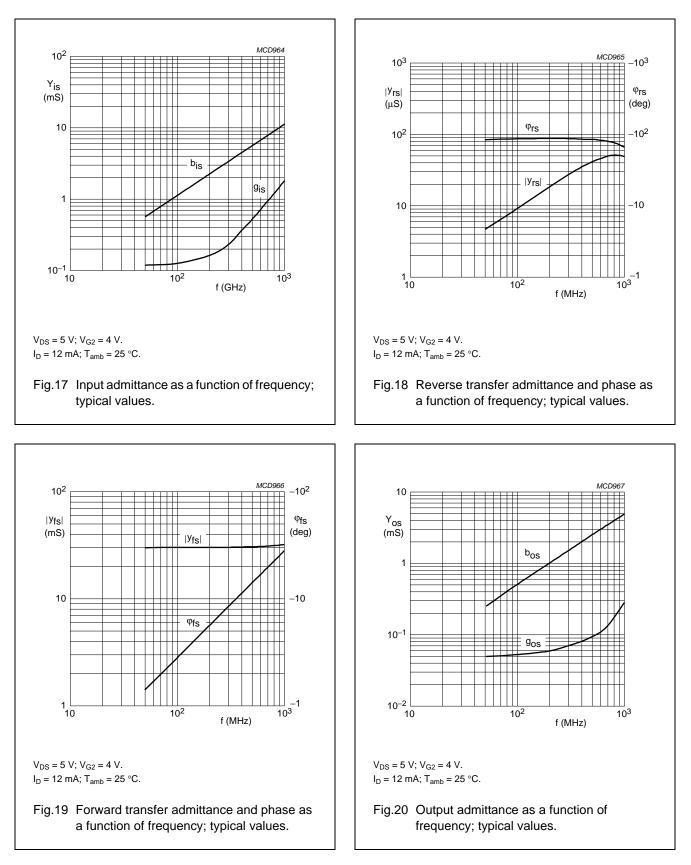


 $\label{eq:VDS} \begin{array}{l} V_{DS}=5~V;~V_{G2\cdot S}=4~V;~T_{j}=25~^{\circ}C.\\ R_{G1}=120~k\Omega~(\text{connected to}~V_{GG});~\text{see Fig.21}. \end{array}$

Fig.10 Drain current as a function of gate 1 supply voltage (= V_{GG}); typical values.







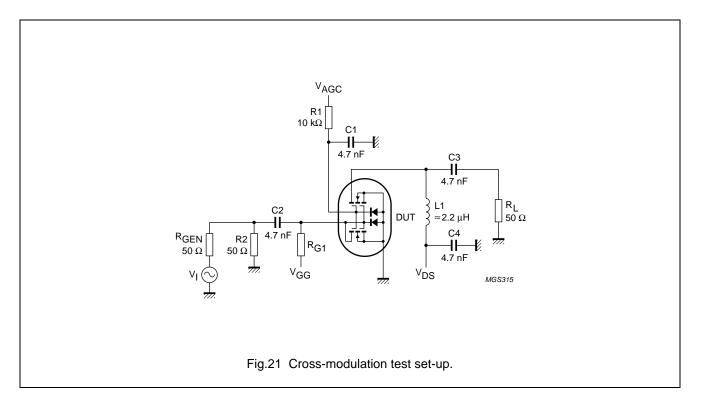


Table 1	Scattering parameters:	$V_{DS} = 5$	V; $V_{G2-S} = 4$	V; I _D = 12 mA;	T _{amb} = 25 °C
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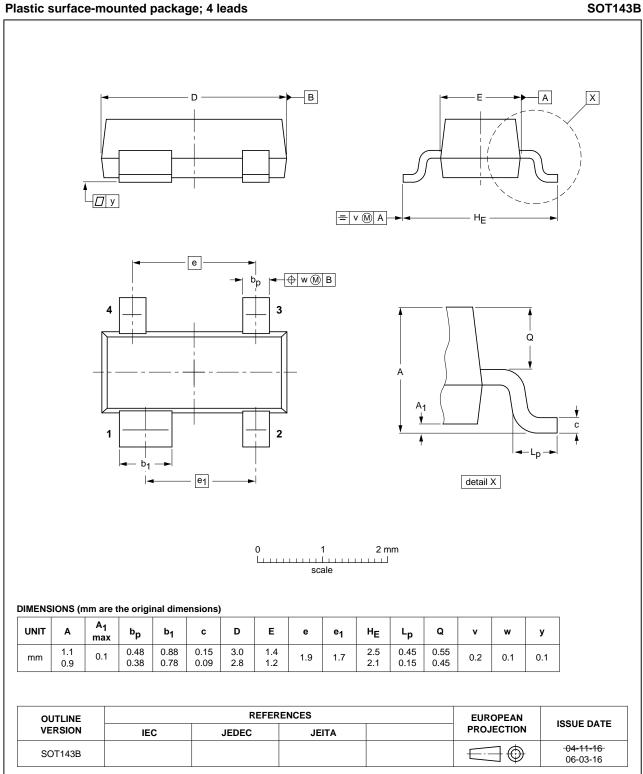
£	s ₁₁		s ₂₁		s ₁₂		s ₂₂		
ı (MHz)	MAGNITUDE (ratio)	ANGLE (deg)	MAGNITUDE (ratio)	ANGLE (deg)	MAGNITUDE (ratio)	ANGLE (deg)	MAGNITUDE (ratio)	ANGLE (deg)	
50	0.988	-3.26	2.989	176.2	0.0005	92.6	0.995	-1.50	
100	0.988	-6.52	3.017	172.5	0.0009	88.0	0.995	-3.01	
200	0.984	-12.99	2.990	165.0	0.0018	82.5	0.994	-5.95	
300	0.977	-19.39	2.949	157.6	0.0027	78.2	0.992	-8.86	
400	0.965	-25.65	2.913	150.3	0.0036	75.4	0.990	-11.79	
500	0.951	-31.76	2.853	143.2	0.0039	71.8	0.988	-14.65	
600	0.936	-37.68	2.793	136.3	0.0042	69.9	0.986	-17.41	
700	0.919	-43.42	2.727	129.5	0.0044	68.9	0.984	-20.10	
800	0.903	-48.94	2.664	123.0	0.0043	68.5	0.980	-22.69	
900	0.887	-54.25	2.593	116.7	0.0041	70.7	0.975	-25.27	
1000	0.870	-59.34	2.518	110.5	0.0038	72.4	0.970	-27.90	

Table 2 Noise data: V_{DS} = 5 V; V_{G2-S} = 4 V; I_D = 12 mA; T_{amb} = 25 °C

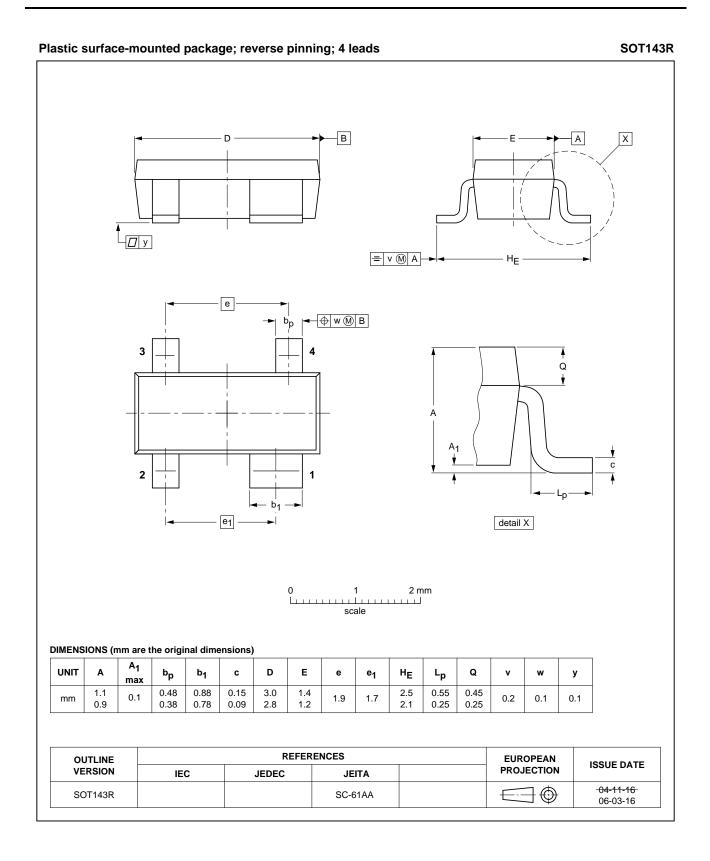
f	F _{min}	Г	opt	R _n
(MHz)	(dB)	(ratio)	(deg)	(Ω)
400	0.9	0.805	28.5	50
800	1.1	0.725	47.2	40

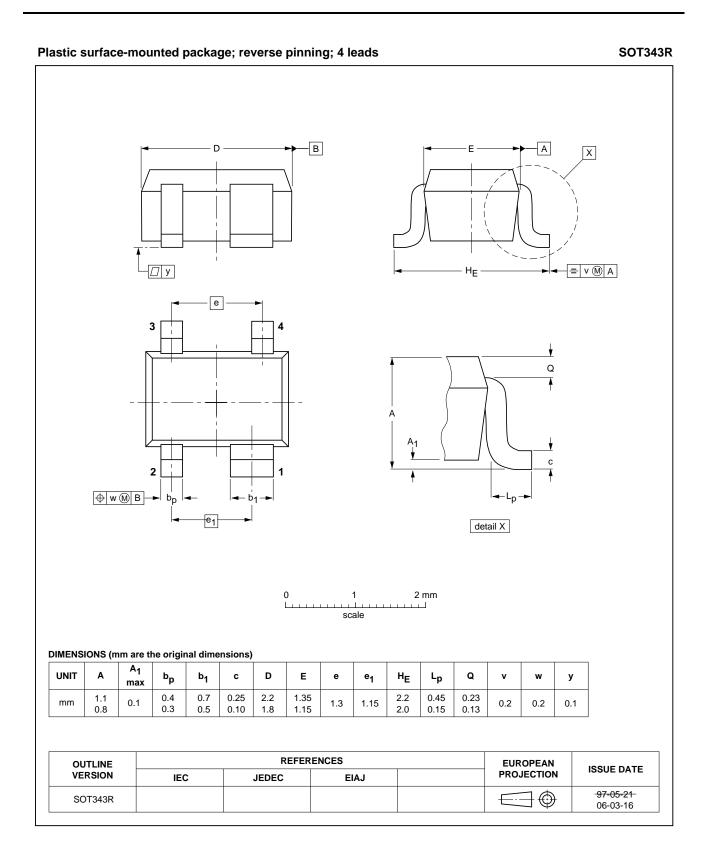
BF1202; BF1202R; BF1202WR

PACKAGE OUTLINES



SOT143B





BF1202; BF1202R; BF1202WR

DATA SHEET STATUS

DOCUMENT STATUS ⁽¹⁾	PRODUCT STATUS ⁽²⁾	DEFINITION
Objective data sheet	Development	This document contains data from the objective specification for product development.
Preliminary data sheet	Qualification	This document contains data from the preliminary specification.
Product data sheet	Production	This document contains the product specification.

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BF1202; BF1202R; BF1202WR

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